

Notice of References Cited

Application/Control No.

09/757,491

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

Jennifer T Nguyen

Art Unit

2674

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,278,242	08-2001	Cok et al.	315/169.1
	B	US-5,349,366	09-1994	Yamazaki et al.	345/92
	C	US-5,463,279	10-1995	Khormaei	315/169.3
	D	US-6,433,488	08-2002	Bu	315/169.3
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.